

Maximum Ratings ($@T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Drain-Source Voltage	V_{DSS}	20	V		
Gate-Source Voltage			V_{GSS}	±10	V
Continuous Prain Current (Note C) V 40V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	10.0 8.0	А
Continuous Drain Current (Note 6) V _{GS} = 10V	t<10s	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	l _D	12.6 10.1	А
Maximum Body Diode Forward Current (Note 6)	Is	2	Α		
Pulsed Drain Current (10μs pulse, Duty cycle = 1%)	I _{DM}	40	Α		
Avalanche Current (Note 7) L = 0.1mH	I _{AS}	15	Α		
Avalanche Energy (Note 7) L = 0.1mH			E _{AS}	11.5	mJ

Thermal Characteristics ($@T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic		Symbol	Value	Units
Total Power Dissipation (Note 5)		P_D	1.2	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	_	107	°C/W
Thermal Resistance, Junction to Ambient (Note 5)	t<10s	$R_{\theta JA}$	67	C/VV
Total Power Dissipation (Note 6)		P_D	1.9	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	7	67	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	$R_{\theta JA}$	42	
Thermal Resistance, Junction to Case		$R_{ heta JC}$	11	
Operating and Storage Temperature Range		$T_{J,}T_{STG}$	-55 to +150	°C

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BV _{DSS}	20	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	_	_	1	μΑ	$V_{DS} = 20V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	_	_	±10	μΑ	$V_{GS} = \pm 10V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	V _{GS(TH)}	0.4	_	1	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	
			10.6	12.5		$V_{GS} = 4.5V, I_D = 4A$	
		_	10.8	13.0		$V_{GS} = 4.0V, I_D = 4A$	
Static Drain-Source On-Resistance	R _{DS(ON)}	_	11.3	14.0	mΩ	$V_{GS} = 3.1V, I_D = 4A$	
		_	12.1	14.5		$V_{GS} = 2.5V, I_D = 4A$	
			15.5	19.5		$V_{GS} = 1.8V, I_D = 4A$	
Diode Forward Voltage	V_{SD}	_	0.7	1.1	V	$V_{GS} = 0V, I_{S} = 5A$	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	C_{iss}	_	1870	_	pF	101/11/101/1	
Output Capacitance	Coss	_	321	_	pF	$V_{DS} = 10V, V_{GS} = 0V,$ - f = 1.0MHz	
Reverse Transfer Capacitance	Crss	-	159	_	pF	1 – 1.01/11/12	
Gate Resistance	R_{g}	1	96	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge (V _{GS} = 4.5V)	Q_{g}	-	21	_	nC		
Total Gate Charge (V _{GS} = 10V)	Q_g	-	46	_	nC	$V_{DS} = 10V$,	
Gate-Source Charge	Q_{gs}	_	2.8	_	nC	$I_D = 6.5A$	
Gate-Drain Charge	Q_{gd}	_	3.6		nC		
Turn-On Delay Time	t _{D(ON)}	_	62	_	ns		
Turn-On Rise Time	t _R	_	102	_	ns	$V_{DS} = 10V, V_{GS} = 4.5V,$ $R_G = 6\Omega, R_L = 1.0\Omega, I_D = 1A$	
Turn-Off Delay Time	t _{D(OFF)}	_	596	_	ns		
Turn-Off Fall Time	t _F	_	224	_	ns		
Reverse Recovery Time	t _{RR}	_	149	_	ns	I _F = 4A, di/dt = 100A/µs	
Reverse Recovery Charge	Q_{RR}		134	_	nC	$I_F = 4A$, di/dt = 100A/ μ s	

Notes: 5. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.

^{6.} Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate.

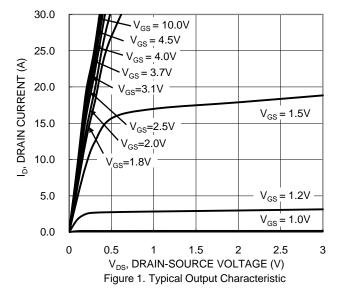
^{7.} I_{AS} and E_{AS} rating are based on low frequency and duty cycles to keep $T_J = +25$ °C.

^{8 .}Short duration pulse test used to minimize self-heating effect.

^{9.} Guaranteed by design. Not subject to production testing.







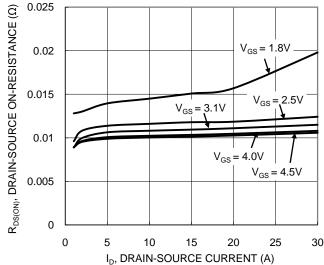


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

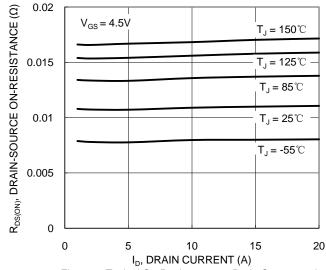
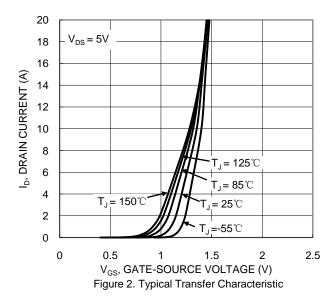
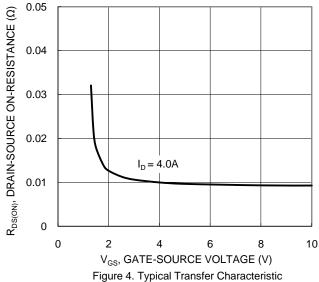


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature





2.5 $\frac{1}{1}$ $\frac{1}{1}$

Figure 6. On-Resistance Variation with Junction Temperature





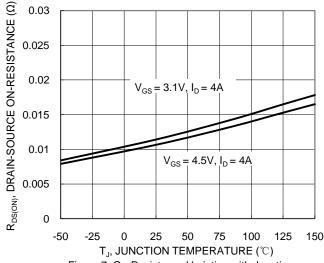
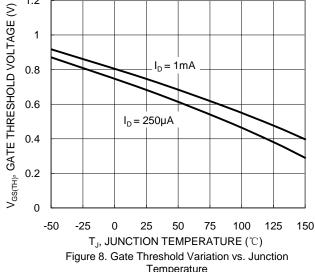


Figure 7. On-Resistance Variation with Junction Temperature



1.2

Temperature

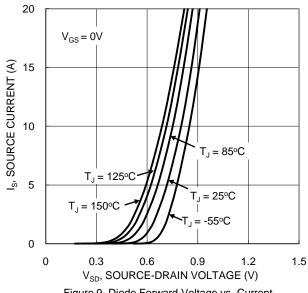
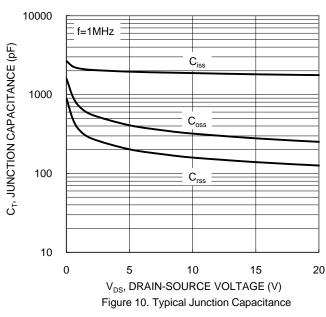
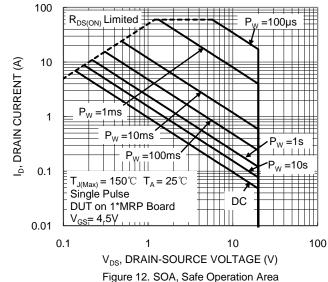


Figure 9. Diode Forward Voltage vs. Current



45 50



 Q_q (nC) Figure 11. Gate Charge

20 25 30 35 40

15

 $V_{DS} = 10V, I_{D} = 6.5A$

0

5 10

10

8

6

4

2

0

 $V_{GS}(V)$



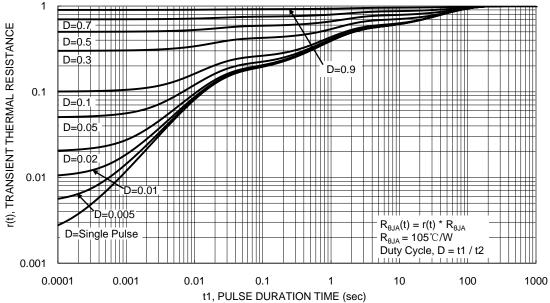


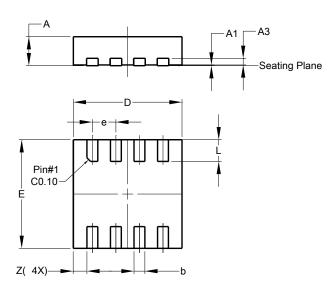
Figure 13. Transient Thermal Resistance



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

V-DFN3030-8

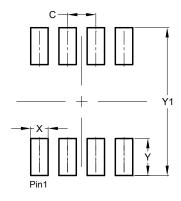


V-DFN3030-8					
Dim	Min	Max	Тур		
Α	0.75	0.85	0.80		
A 1	0.00	0.05	0.02		
A3	-	-	0.203		
b	0.25	0.35	0.30		
D	2.95	3.05	3.00		
Е	2.95	3.05	3.00		
е	-	-	0.65		
L	0.55	0.65	0.60		
Z	-	-	0.375		
All Dimensions in mm					

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

V-DFN3030-8



Dimensions	Value (in mm)		
С	0.650		
Х	0.400		
Y	0.850		
Y1	3 400		



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